

## General Description

The HSCC8211 is the low RDSON trenched N-CH MOSFETs with robust ESD protection. This product is suitable for Lithium-ion battery pack applications.

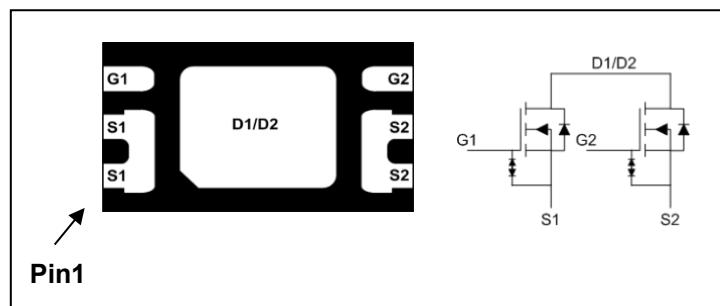
The HSCC8211 meet the RoHS and Green Product requirement with full function reliability approved.

- Low drain-source ON resistance
- Green Device Available
- ESD Protected Embedded

## Product Summary

V <sub>DS</sub>	20	V
R <sub>DS(ON),max</sub>	13	mΩ
I <sub>D</sub>	8	A

## DFN2x3 Pin Configuration



## Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	20	V
V <sub>GS</sub>	Gate-Source Voltage	±12	V
I <sub>D</sub> @T <sub>A</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ 4.5V <sub>1</sub>	8	A
I <sub>D</sub> @T <sub>A</sub> =70°C	Continuous Drain Current, V <sub>GS</sub> @ 4.5V <sub>1</sub>	6.4	A
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup>	50	A
P <sub>D</sub> @T <sub>A</sub> =25°C	Total Power Dissipation <sub>1</sub>	1.56	W
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
T <sub>J</sub>	Operating Junction Temperature Range	-55 to 150	°C

## Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
R <sub>θJA</sub>	Thermal Resistance Junction-Ambient <sub>1</sub> (t ≤10s)	---	80	°C/W



**N-Channel Electrical Characteristics ( $T_J=25^{\circ}\text{C}$ , unless otherwise noted)**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$\text{V}_{\text{GS}}=0\text{V}$ , $\text{I}_D=250\mu\text{A}$	20	---	---	V
$\text{R}_{\text{DS(ON)}}$	Static Drain-Source On-Resistance <sup>2</sup>	$\text{V}_{\text{GS}}=4.5\text{V}$ , $\text{I}_D=2\text{A}$	7	9	13	$\text{m}\Omega$
		$\text{V}_{\text{GS}}=4.0\text{V}$ , $\text{I}_D=2\text{A}$	7.5	9.5	13.5	
		$\text{V}_{\text{GS}}=3.7\text{V}$ , $\text{I}_D=2\text{A}$	8	10	14.5	
		$\text{V}_{\text{GS}}=3.1\text{V}$ , $\text{I}_D=2\text{A}$	8.5	11	16.5	
		$\text{V}_{\text{GS}}=2.5\text{V}$ , $\text{I}_D=2\text{A}$	9.5	12.5	20	
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	$\text{V}_{\text{GS}}=\text{V}_{\text{DS}}$ , $\text{I}_D=250\mu\text{A}$	0.5	---	1.2	V
$\text{I}_{\text{DSS}}$	Drain-Source Leakage Current	$\text{V}_{\text{DS}}=16\text{V}$ , $\text{V}_{\text{GS}}=0\text{V}$ , $\text{T}_J=25^{\circ}\text{C}$	---	---	1	$\text{uA}$
		$\text{V}_{\text{DS}}=16\text{V}$ , $\text{V}_{\text{GS}}=0\text{V}$ , $\text{T}_J=55^{\circ}\text{C}$	---	---	5	
$\text{I}_{\text{GSS}}$	Gate-Source Leakage Current	$\text{V}_{\text{GS}}=\pm 8\text{V}$ , $\text{V}_{\text{DS}}=0\text{V}$	---	---	$\pm 10$	$\text{uA}$
$\text{g}_{\text{fs}}$	Forward Transconductance	$\text{V}_{\text{DS}}=5\text{V}$ , $\text{I}_D=4\text{A}$	---	32	---	S
$\text{Q}_g$	Total Gate Charge (4.5V)	$\text{V}_{\text{DS}}=15\text{V}$ , $\text{V}_{\text{GS}}=4.5\text{V}$ , $\text{I}_D=3\text{A}$	---	10.6	---	$\text{nC}$
$\text{Q}_{\text{gs}}$	Gate-Source Charge		---	2.2	---	
$\text{Q}_{\text{gd}}$	Gate-Drain Charge		---	4.1	---	
$\text{T}_{\text{d(on)}}$	Turn-On Delay Time	$\text{V}_{\text{DD}}=15\text{V}$ , $\text{V}_{\text{GS}}=4.5\text{V}$ , $\text{R}_G=6\Omega$	---	7	---	$\text{ns}$
$\text{T}_r$	Rise Time		---	36	---	
$\text{T}_{\text{d(off)}}$	Turn-Off Delay Time		---	46.5	---	
$\text{T}_f$	Fall Time		---	15	---	
$\text{C}_{\text{iss}}$	Input Capacitance	$\text{V}_{\text{DS}}=10\text{V}$ , $\text{V}_{\text{GS}}=0\text{V}$ , $f=1\text{MHz}$	---	735	---	$\text{pF}$
$\text{C}_{\text{oss}}$	Output Capacitance		---	83	---	
$\text{C}_{\text{rss}}$	Reverse Transfer Capacitance		---	81	---	

**Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
$\text{I}_s$	Continuous Source Current <sup>1</sup>	$\text{V}_G=\text{V}_D=0\text{V}$ , Force Current	---	---	8	A
$\text{I}_{\text{SM}}$	Pulsed Source Current <sup>2</sup>		---	---	50	A
$\text{V}_{\text{SD}}$	Diode Forward Voltage <sup>2</sup>	$\text{V}_{\text{GS}}=0\text{V}$ , $\text{I}_s=8.0\text{A}$ , $\text{T}_J=25^{\circ}\text{C}$	---	---	1.2	V

Note :

- 1.The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper,  $t \leq 10\text{s}$ .
- 2.The data tested by pulsed , pulse width  $\leq 10\text{us}$  , duty cycle  $\leq 1\%$



### Typical Characteristics

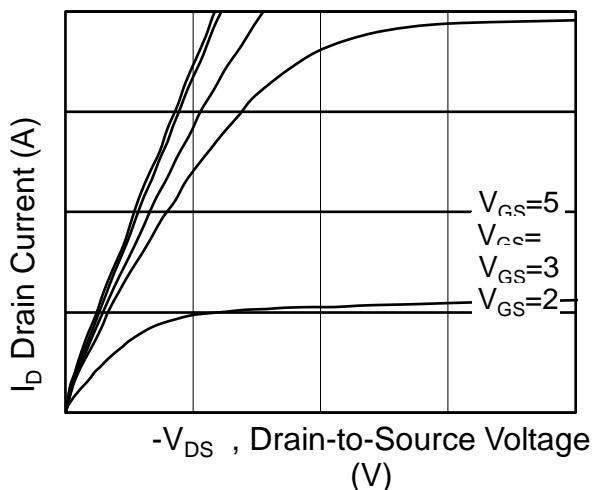


Fig.1 Typical Output Characteristics

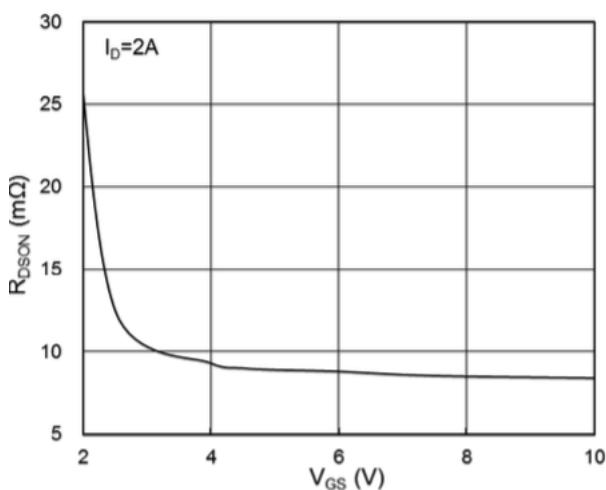


Fig.2 On-Resistance vs. G-S Voltage

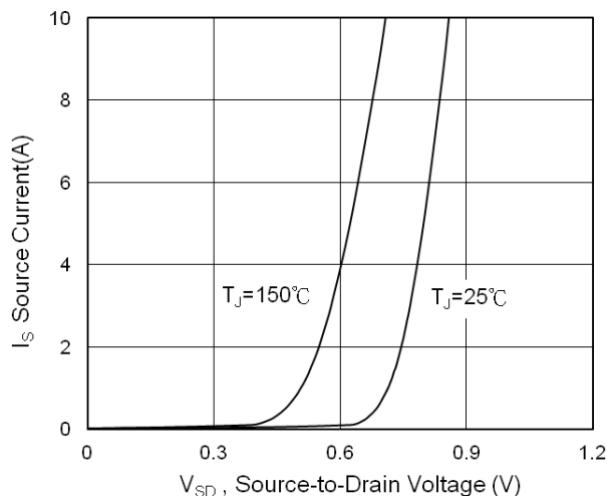


Fig.3 Forward Characteristics of Reverse

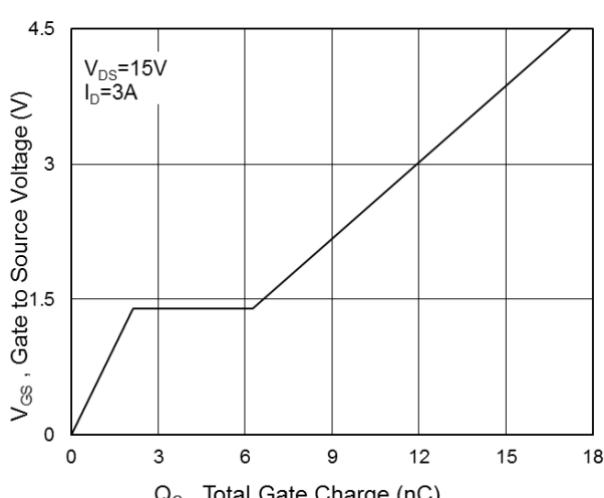


Fig.4 Gate-Charge Characteristics

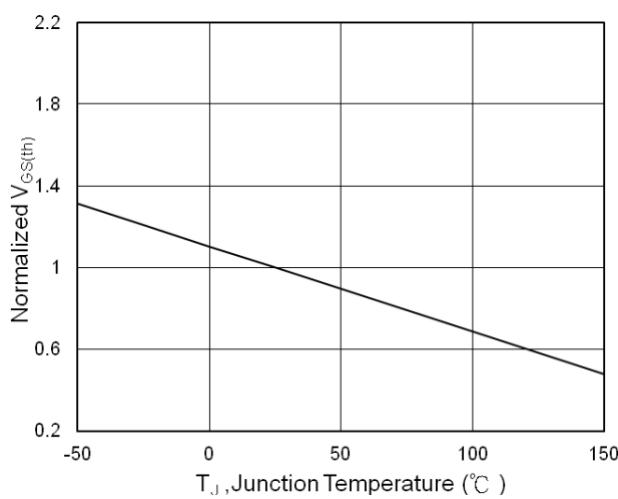


Fig.5 V<sub>GS(th)</sub> vs. T<sub>J</sub>

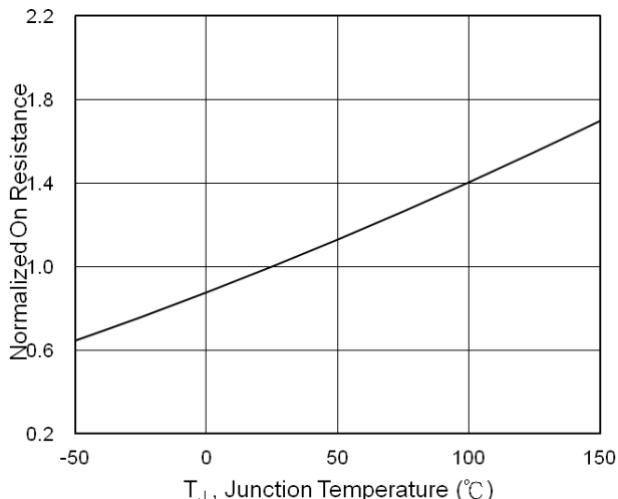


Fig.6 Normalized R<sub>DSON</sub> vs. T<sub>J</sub>



HUASHUO  
SEMICONDUCTOR

HSCC8211

## Dual N-Ch Fast Switching MOSFETs

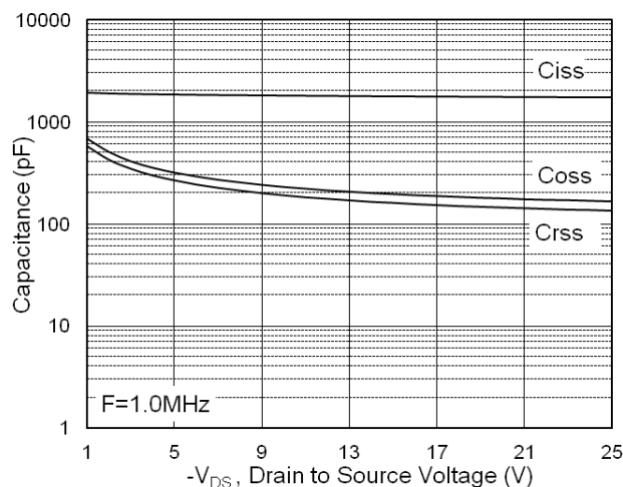


Fig.7 Capacitance

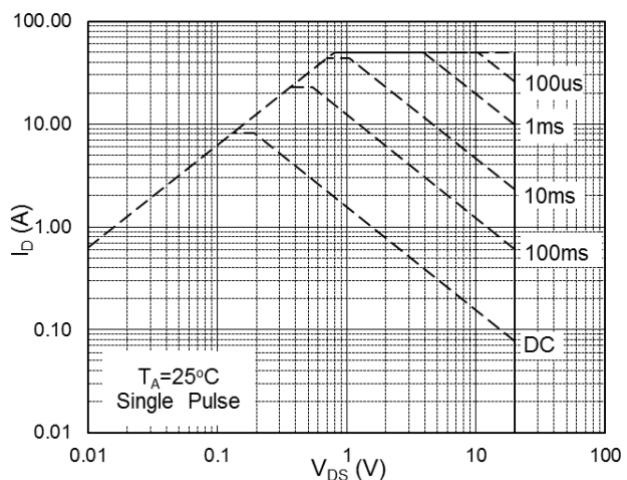


Fig.8 Safe Operating Area

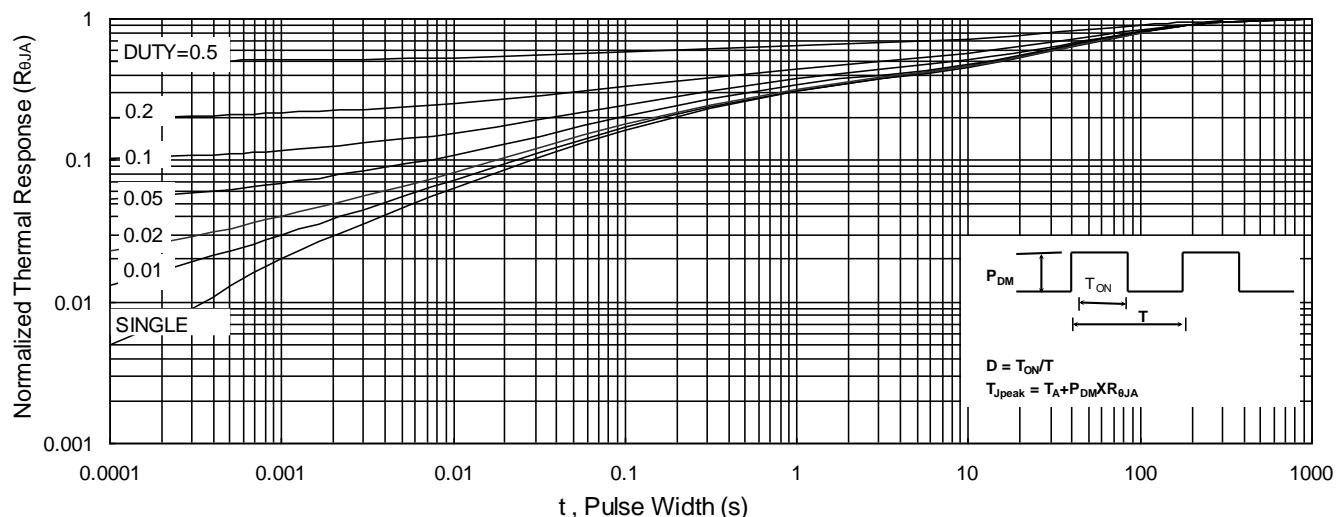


Fig.9 Normalized Maximum Transient Thermal Impedance

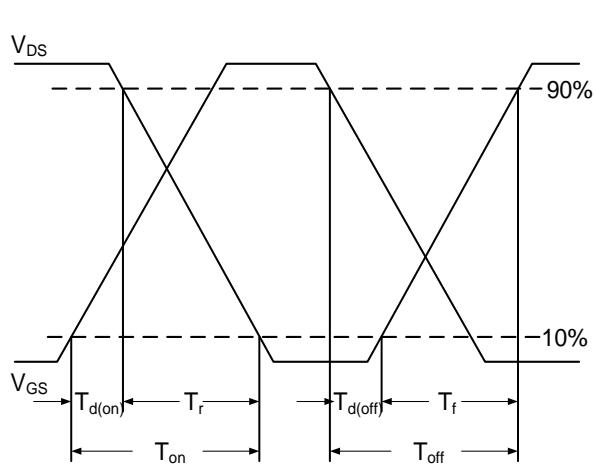


Fig.10 Switching Time Waveform

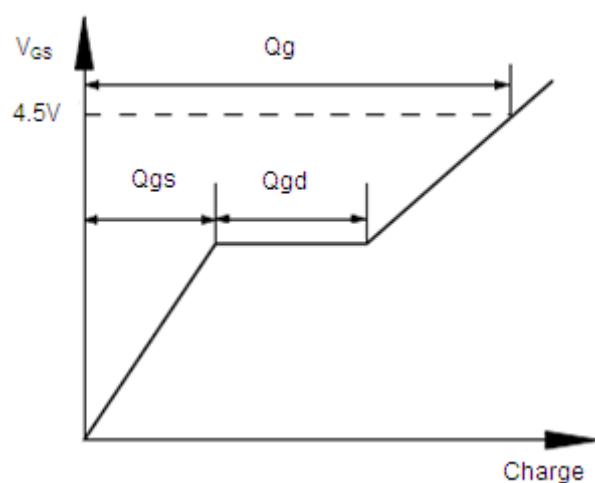
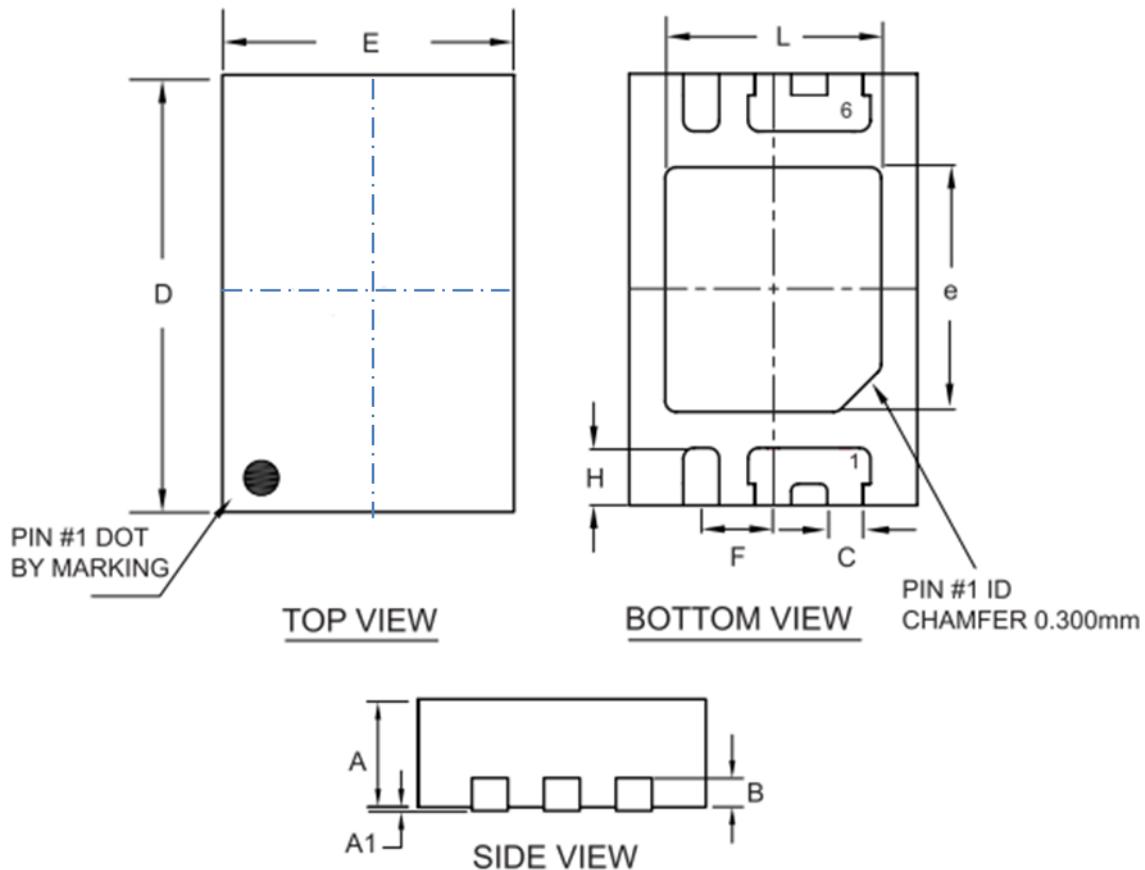


Fig.11 Gate Charge Waveform



## DFN2x3 Package Outline Dimensions



SYMBOLS	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	0.700	0.800	0.028	0.031
A1	0.000	0.050	0.000	0.002
D	2.950	3.050	0.116	0.120
E	1.950	2.050	0.077	0.081
H	0.350	0.450	0.014	0.018
L	1.450	1.550	0.057	0.061
e	1.650	1.750	0.065	0.069
B	0.195	0.211	0.0076	0.008
C	0.200	0.300	0.008	0.012
F	0.500 BSC		0.020 BSC	